



BSI Standards Publication

Semiconductor devices

Part 5-14: Optoelectronic devices — Light emitting diodes — Test method of the surface temperature based on the thermoreflectance method

National foreword

This British Standard is the UK implementation of IEC 60747-5-14:2022.

The UK participation in its preparation was entrusted to Technical Committee EPL/47, Semiconductors.

A list of organizations represented on this committee can be obtained on request to its committee manager.

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Published by BSI Standards Limited 2024

ISBN 978 0 539 14397 3

ICS 31.080.99

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This British Standard was published under the authority of the Standards Policy and Strategy Committee on 30 September 2024.

Amendments/corrigenda issued since publication

Date	Text affected
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